

Search Notes

Application/Control No.

10/764,442

Examiner

Devin Hanan

Applicant(s)/Patent under
Reexamination

TSURU ET AL.

Art Unit

3745

SEARCHED

Class	Subclass	Date	Examiner
415	209.4		
	208.2		
	191		
	209.3		
	209.2		
	189		
	190	5/11/2005	DH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
all of	the above	5/11/2005	DH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted Ninh Nguyen on classes 415 and 416	5/9/2005	DH
consulted Chris Verdier on classes 415 and 416	5/10/2005	DH